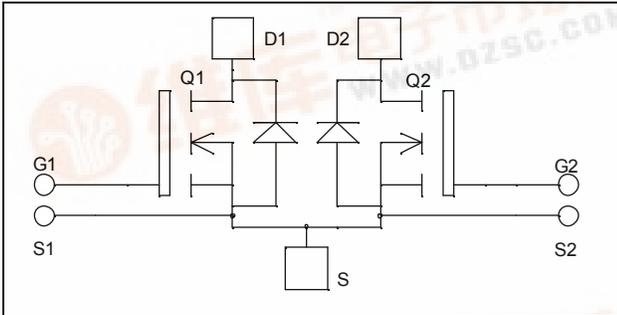




# APTMI0DUM02G

## Dual Common Source MOSFET Power Module

$V_{DSS} = 100V$   
 $R_{DSon} = 2.25m\Omega$  typ @  $T_j = 25^\circ C$   
 $I_D = 495A$  @  $T_c = 25^\circ C$

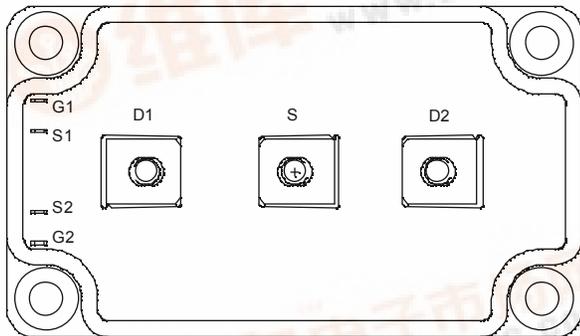


### Application

- AC Switches
- Switched Mode Power Supplies
- Uninterruptible Power Supplies

### Features

- Power MOS V<sup>®</sup> MOSFETs
  - Low  $R_{DSon}$
  - Low input and Miller capacitance
  - Low gate charge
  - Avalanche energy rated
  - Very rugged
- Kelvin source for easy drive
- Very low stray inductance
  - Symmetrical design
  - M5 power connectors
- High level of integration



### Benefits

- Outstanding performance at high frequency operation
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Low profile
- RoHS Compliant

### Absolute maximum ratings

Symbol	Parameter	Max ratings	Unit
$V_{DSS}$	Drain - Source Breakdown Voltage	100	V
$I_D$	Continuous Drain Current	$T_c = 25^\circ C$	495
		$T_c = 80^\circ C$	370
$I_{DM}$	Pulsed Drain current	1900	A
$V_{GS}$	Gate - Source Voltage	$\pm 30$	V
$R_{DSon}$	Drain - Source ON Resistance	2.5	$m\Omega$
$P_D$	Maximum Power Dissipation	$T_c = 25^\circ C$	1250
$I_{AR}$	Avalanche current (repetitive and non repetitive)	100	A
$E_{AR}$	Repetitive Avalanche Energy	50	mJ
$E_{AS}$	Single Pulse Avalanche Energy	3000	



All ratings @  $T_j = 25^\circ\text{C}$  unless otherwise specified

**Electrical Characteristics**

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{GS} = 0\text{V}, V_{DS} = 100\text{V}$			400	$\mu\text{A}$
		$V_{GS} = 0\text{V}, V_{DS} = 80\text{V}$	$T_j = 125^\circ\text{C}$		2000	
$R_{DS(on)}$	Drain – Source on Resistance	$V_{GS} = 10\text{V}, I_D = 200\text{A}$		2.25	2.5	$\text{m}\Omega$
$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_D = 10\text{mA}$	2		4	V
$I_{GSS}$	Gate – Source Leakage Current	$V_{GS} = \pm 30\text{V}, V_{DS} = 0\text{V}$			$\pm 400$	$\text{nA}$

**Dynamic Characteristics**

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
$C_{iss}$	Input Capacitance	$V_{GS} = 0\text{V}$		40		$\text{nF}$
$C_{oss}$	Output Capacitance	$V_{DS} = 25\text{V}$		15.7		
$C_{rss}$	Reverse Transfer Capacitance	$f = 1\text{MHz}$		5.9		
$Q_g$	Total gate Charge	$V_{GS} = 10\text{V}$ $V_{Bus} = 50\text{V}$ $I_D = 400\text{A}$		1360		$\text{nC}$
$Q_{gs}$	Gate – Source Charge			240		
$Q_{gd}$	Gate – Drain Charge			720		
$T_{d(on)}$	Turn-on Delay Time	<b>Inductive switching @ <math>125^\circ\text{C}</math></b> $V_{GS} = 15\text{V}$ $V_{Bus} = 66\text{V}$ $I_D = 400\text{A}$ $R_G = 1.25\Omega$		160		$\text{ns}$
$T_r$	Rise Time			240		
$T_{d(off)}$	Turn-off Delay Time			500		
$T_f$	Fall Time			160		
$E_{on}$	Turn-on Switching Energy	<b>Inductive switching @ <math>25^\circ\text{C}</math></b> $V_{GS} = 15\text{V}, V_{Bus} = 66\text{V}$ $I_D = 400\text{A}, R_G = 1.25\Omega$		2.2		$\text{mJ}$
$E_{off}$	Turn-off Switching Energy			2.41		
$E_{on}$	Turn-on Switching Energy	<b>Inductive switching @ <math>125^\circ\text{C}</math></b> $V_{GS} = 15\text{V}, V_{Bus} = 66\text{V}$ $I_D = 400\text{A}, R_G = 1.25\Omega$		2.43		$\text{mJ}$
$E_{off}$	Turn-off Switching Energy			2.56		

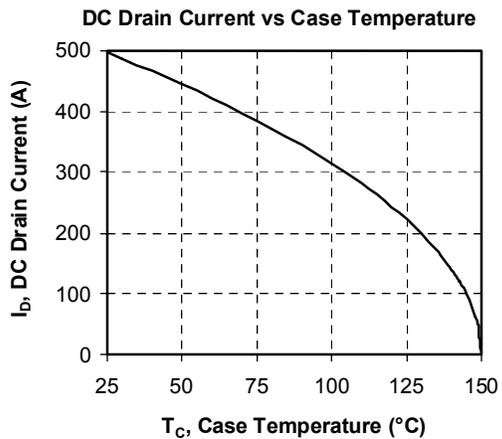
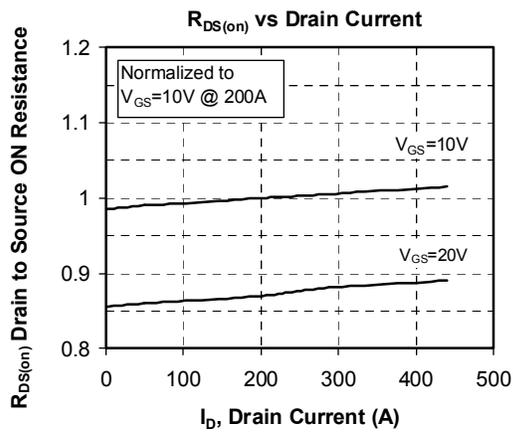
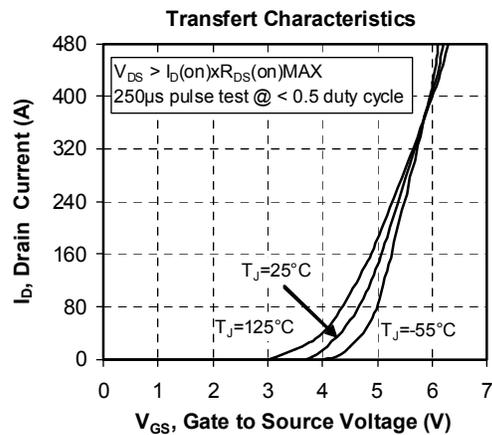
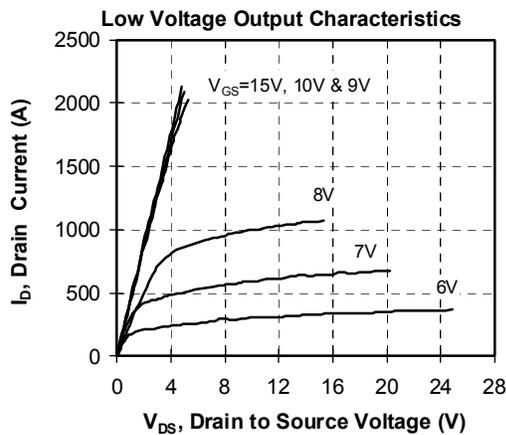
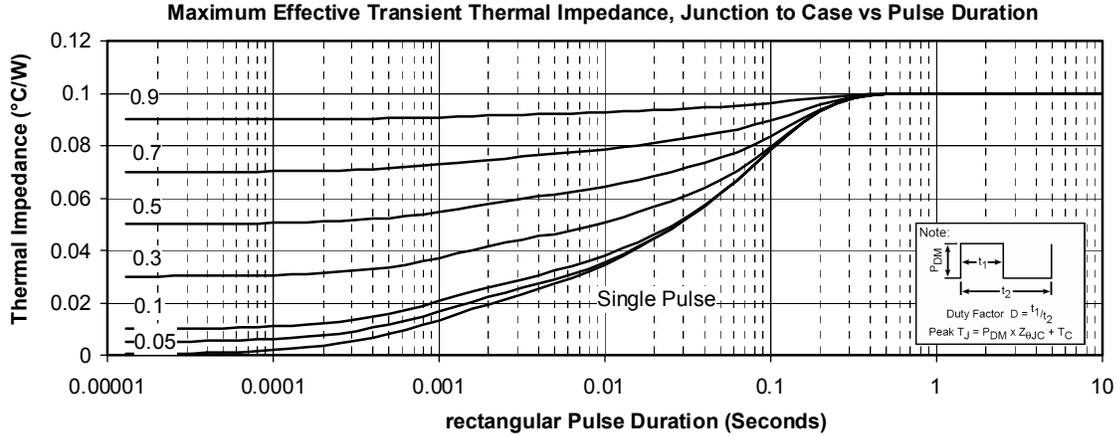
**Source - Drain diode ratings and characteristics**

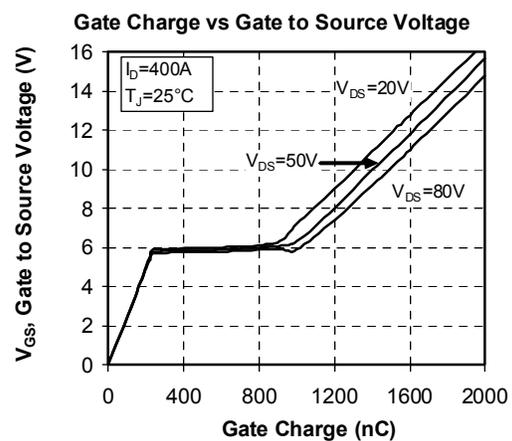
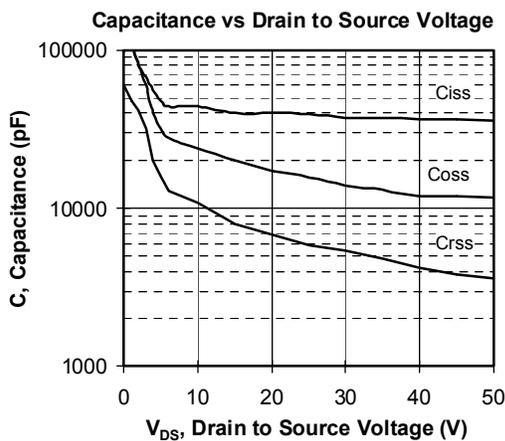
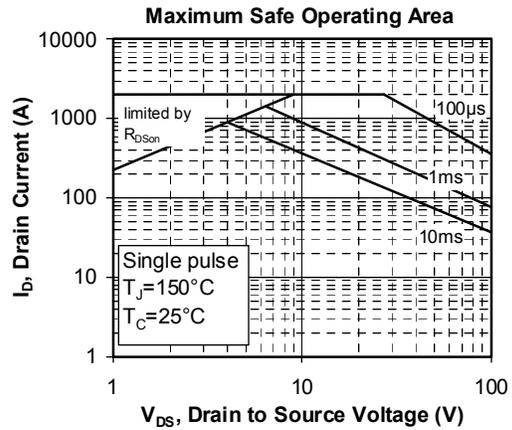
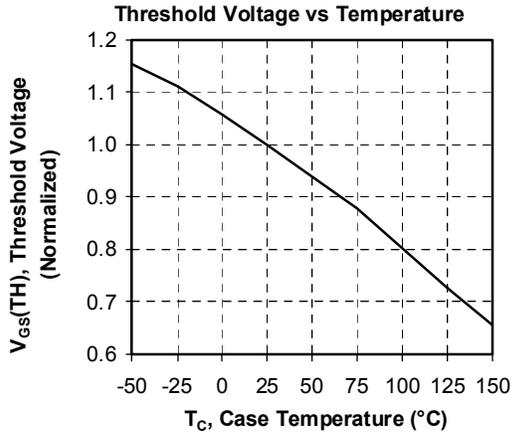
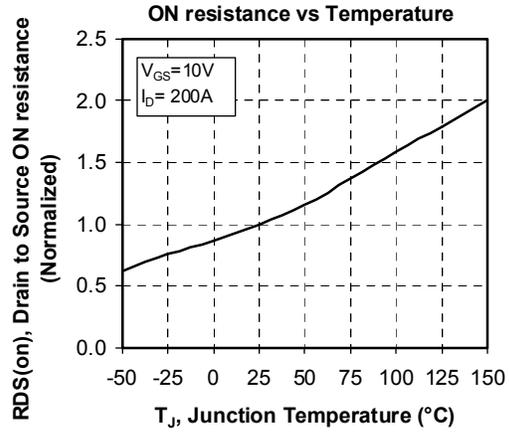
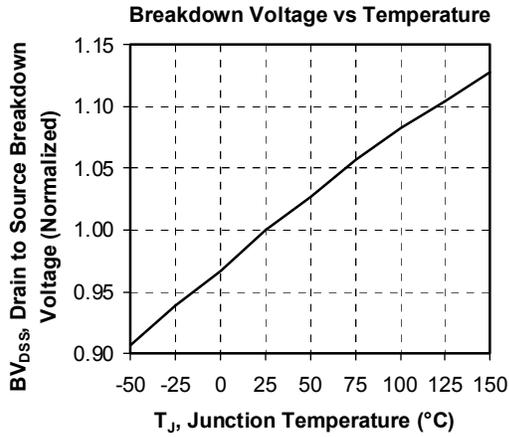
Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
$I_S$	Continuous Source current (Body diode)		$T_c = 25^\circ\text{C}$		495	A
			$T_c = 80^\circ\text{C}$		370	
$V_{SD}$	Diode Forward Voltage	$V_{GS} = 0\text{V}, I_S = -400\text{A}$			1.3	V
$dv/dt$	Peak Diode Recovery ①				5	V/ns
$t_{rr}$	Reverse Recovery Time	$I_S = -400\text{A}$ $V_R = 66\text{V}$	$T_j = 25^\circ\text{C}$		270	$\text{ns}$
$Q_{rr}$	Reverse Recovery Charge	$di/dt = 400\text{A}/\mu\text{s}$	$T_j = 25^\circ\text{C}$		11.6	$\mu\text{C}$

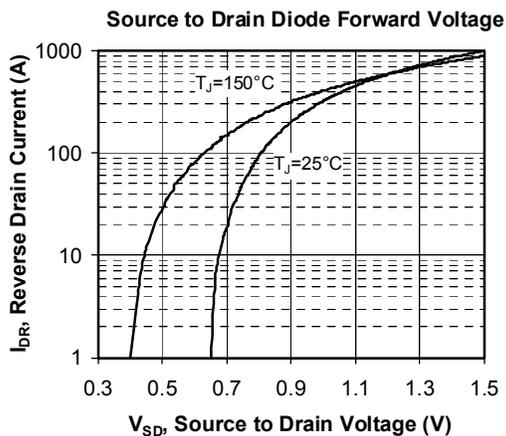
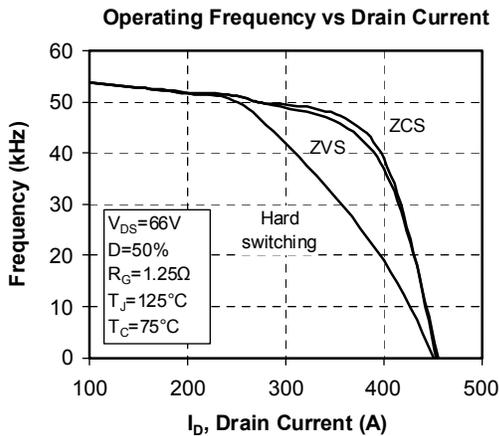
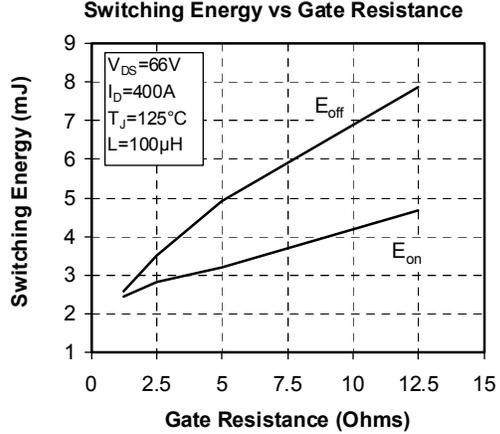
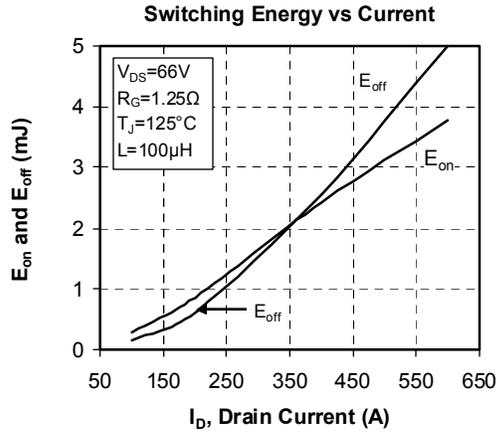
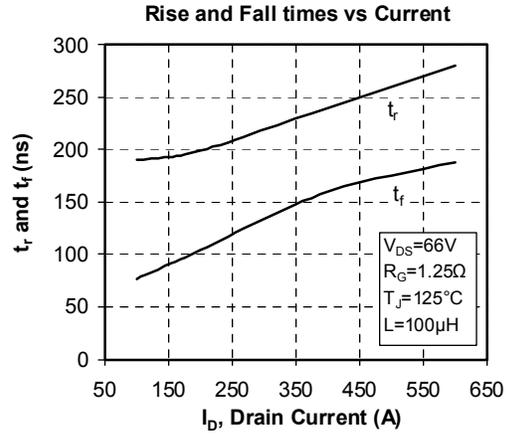
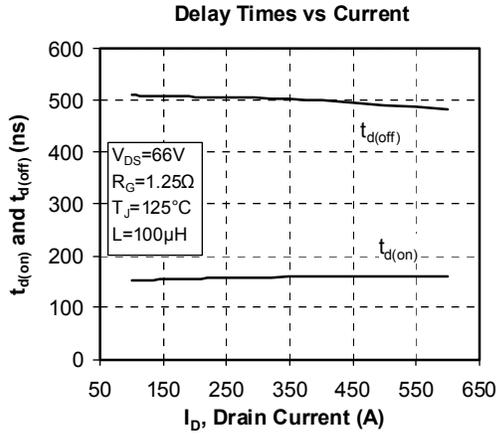
①  $dv/dt$  numbers reflect the limitations of the circuit rather than the device itself.

$$I_S \leq -495\text{A} \quad di/dt \leq 400\text{A}/\mu\text{s} \quad V_R \leq V_{DSS} \quad T_j \leq 150^\circ\text{C}$$



**Typical Performance Curve**






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